In-P lane M agnetodrag between D ilute Two-D im ensional System s

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W e perform ed in-plane m agnetodrag m easurem ents on dilute double layer two-dim ensional hole system s, at in-plane m agnetic elds that suppress the apparent m etallic behavior, and to elds well above those required to fully spin polarize the system. W hen compared to the single layer m agnetoresistance, the m agnetodrag exhibits exactly the same qualitative behavior. In addition, we have found that the enhancem ent to the drag from the in-plane eld exhibits a strong m axim um when both layer densities are m atched.

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The unexpected observation of a metallic phase and an apparent metal to insulator transition in two dimensional (2D) system s[1], contradictory to the scaling theory of localization [2], has been the subject of extensive experim ental and theoretical work in recent years [3]. Despite this, there remains no conclusive understanding of the origin of the metallic behavior, and whether or not the system can be described in a Fermi liquid fram ework. More recently, the role the electronic spin plays in the metallic phase was considered by applying a magnetic eld in the plane of the 2D carriers (B_{ii}). The application of B_{ii}, which polarizes the spins of the carriers, has been dem onstrated to suppress the metallic behavior[4, 5]. To date, there is still no de nitive explanation for why the metallic behavior is suppressed, when the carrier spins are polarized. A lso, the role carrier-carrier interaction plays in the spin polarized regime is unclear. A lthough some information can be inferred about carrier-carrier interaction from single layer transport m easurem ents in these system s, such as weaklocalization like corrections[6, 7], the near translational invariance of these system s prevents any direct m easurem ent of the carrier-carrier scattering rate. On the other hand, double layer structures provide a system in which, carrier-carrier interaction can be studied directly. This arises from the fact that now, single layer momentum conservation has been relaxed. Drag m easurem ent[8], performed by driving a current (I_D) through one of the layers, and m easuring the potential $(V_{\mbox{\scriptsize D}}$), which arises in the other layer due to m om entum transfer, allow s one to measure the interlayer carrier-carrier interactions directly. The drag resistivity $(_{D})$, given by $V_{D} = I_{D}$, is directly proportional to the interlayer carrier-carrier scattering rate. In this sense the drag is a very pow erful tool, and it has been used in the past to study a variety of di erent electronic states[9]. Here, we study the drag as the system is spin polarized, to gain insight into the role interactions and spin play in the 2D m etallic phase.

In this paper, we present drag m easurements, on dilute double layer hole systems, in an in-plane m agnetic eld. We accompany these data by the corresponding single layer in-plane m agnetoresistance (MR) m easurem ents. W e would like to point out that here we have studied the drag in the exact sam e regim e in which, num erous single layer in-plane magnetotransport experiments have been perform ed[3]. The layer densities of our measurements ranged from $3.25 \text{ to } 0.9 \quad 10^{10} \text{ cm}^{-2}$, all of which exhibited metallic behavior at B = 0.0 ur eld measurements ranged up to 14 T, well above the elds required to drive the system insulating or to fully spin polarize the carriers. The magnetodrag traces were taken at di erent temperatures (T) and di erent matched layer densities (p_m). Our main observation is that the magnetodrag shows exactly the sam e qualitative behavior as the single layer M R. In addition, quite unexpectedly, we have found that the enhancement to D from B jj is strongly dependent upon the layer densities being matched.

The sample used in this study is a Si -doped double GaAs quantum well structure, which was grown by molecular beam epitaxy on a (311)A GaAs substrate. We have used the same sample in our earlier letter[10] on the drag in this dilute regime at B = 0. The sam - ple structure consists of two 150 A GaAs quantum wells separated by a 150 A A lAs barrier, corresponding to a center to center layer separation of 300 A. The average grown densities and low tem perature mobilities of each layer are 2.5 10^{10} cm² and 1.5 10^5 cm²/V s, respectively. The sam ple was processed allow ing independent contact to each of the two layers, using a selective depletion scheme [11]. In addition, both layer densities are independently tunable using evaporated m etallic gates.

The data presented in this paper were taken in a top loading dilution refrigerator, with a base temperature of 60 m K. The sample was mounted on the end of a tilting probe, with which the sample could be rotated, in situ, from 0 to 90 degrees relative to the eld. The densities in each layer were determ ined by independently measuring Shubnikov-de Haas oscillations. We point out that all of the in-plane eld measurements presented here were done with the magnetic eld aligned perpendicular to the current direction. Drive currents between 50 pA to 2 nA were passed, in the [233] direction, through one of the layers, while the drag signal was measured in the other layer, using standard lock-in techniques at 4 Hz.





FIG.1: In-plane magnetotransport data for $p_m = 2:15 \quad 10^{10}$ cm² at T = 80, 175, 250, and 400 mK. (a) Inset: vs B_{jj}. B_c and B are indicated by the arrow and the dashed line, respectively. Main Plot: Data from inset normalized by its B_{jj} = 0 value. (b) Inset: Corresponding data for _D vs B_{jj}. Main Plot: Data from inset normalized by its B_{jj} = 0 value.

To ensure that no spurious sources were contributing to our signal, all the standard consistency checks associated with the drag technique were perform ed [8, 10].

We begin our presentation of the data, by rst looking at the B $_{\dagger\dagger}$ dependence of $_{\rm D}$ and the single layer re-10¹⁰ sistivity () at matched layer densities of 2:15 cm². This is presented in Fig. 1, for T = 80, 175, 250, and 400 mK. In the inset of Fig. 1 (a), the single layer in-plane MR is presented [12]. Here sim ilar behavior to that reported in previous single layer studies is observed [3, 5, 7]. At low elds, the MR is well described by a $aB^2 + c$ t. A crossing point (B_c), indicating a transition from metallic-like (d =dT > 0) to insulating behavior (d =dT < 0), is observed at a eld of $B_c = 3 T$. The characteristic \shoulder" (B), indicating the onset of full spin polarization [13] is also seen at B = 5:3 T. In addition, for elds B > B , the system exhibits positive MR, consistent with previous reports in GaAs[5, 7, 14]. In Fig.1 (a), this data is presented, norm a lized by its zero

eld value. The corresponding norm alized drag data is plotted in Fig. 1 (b) . Note here the strikingly sim ilar behavior to that seen in the norm alized single layer M R

FIG.2: and $_{\rm D}$ vsB_{jj} at T = 80 mK for di erent densities. (a) Inset: vsB_{jj} for (from bottom to top) p = 3.25, 2.15, 1.75, 1.5 and 1.2 10^{10} cm². Main Plot: Data from inset normalized by its B_{jj} = 0 value. (b) Inset: $_{\rm D}$ vsB_{jj} for (from bottom to top) p_m = 2.15, 1.75, 1.5, and 1.2 10^{10} cm². Main Plot: Data from inset normalized by its B_{jj} = 0 value. Density for each trace is indicated in the legend.

in Fig.1 (a). In both cases, the dependence at low elds is well described by a quadratic increase. A lso, the drag shows a crossover to a weaker dependence at exactly the same eld of 5.3 T, where B is observed in the single layer. In addition, the drag increases with eld above B , just like in the single layer transport. A lso, in both cases, the trace becomes much sharper and shows more increase as T is lowered. In the inset of Fig. 1 (b), the raw drag data is presented. Note that the only di erence observed is the absence of a crossing point in the drag, indicating that here $_{\rm D}$ exhibits a monotonically increasing T dependence at all elds.

Next, we turn our attention to the B_{jj} dependence of _D and at di erent m atched densities at T = 80 mK, which is presented in Fig. 2. In the inset of Fig. 2 (a), the single layer in-plane MR is plotted for densities of 3.25, 2.15, 1.75, 1.5, and 1.2 10^{10} cm^2 . Note here that our data reproduces the same qualitative trends previously reported, namely, that B shifts to lower eld as the density is lowered [3, 4, 5, 7]. A lthough not show n due to space limitations, if B is plotted vs density, a linear

dependence with positive intercept, in agreement with previous reports in GaAs[5, 7], is obtained. In the inset of Fig. 2 (b), we plot the corresponding drag data [15]. A gain, we observe qualitatively the sam e trends observed in the single layer transport; B, deduced from the magnetodrag, decreases as pm is low ered, and if plotted vs pm a linear twith positive intercept is obtained. A lthough, the B $_{\rm jj}$ dependence of both and $_{\rm D}$ exhibit the same qualitative trends, quite interesting di erences becom e evident when they are normalized by their $B_{ij} = 0$ values. This is presented in Fig. 2 (a) and (b), respectively. The single layer transport data in Fig. 2 (a), reveal that as the density is low ered the enhancem ent to the resistivity increases. This observation is consistent with num erous studies performed in the past [5, 7, 13]. Note that the norm alized drag data, in Fig. 2 (b), look quite di erent from the normalized single layer traces. At low elds, the data seem to collapse, indicating that the enhancement from B_{ii} is independent of matched density. This im plies that the m atched density dependence of $_{\rm D}$ (a ${\rm p_m^{5}}$ power law was found at low tem peratures for $B_{ii} = 0$) is una ected by a small parallel magnetic eld. At higher

elds, we nd the opposite trend to what we see in the single layer. Here $_{\rm D}$ shows more enhancement at higher m atched density, unlike the single layer resistivity whose enhancement is largest at lower density. In addition, at these higher elds, roughly de ned by B > B, it is clear the dependence of $_{\rm D}$ on $p_{\rm m}$ starts to deviate signicantly from that found at B $_{\rm ti}=0.$

Finally, we conclude our study by investigating how $_{\rm D}$ is a ected by m ism atching the layer densities in the presence of a parallel m agnetic eld. In Fig. 3 we plot $_{\rm D}$ vs the drive layer density (pdrive) at T = 300 mK, for B $_{\rm jj}$ = 0,2,3,5.3,10 and 14 T. Here the drag layer density (pdrag) is xed at 2:15 10^{10} cm 2 and pdrive is swept from 3.25 to 0:9 10^{10} cm 2 . Note that at zero eld we nd a strictly m onotonic dependence as observed earlier, with no signature at m atched density [10]. In general, we have found that at zero eld, for T $^<$ 0.5Tr (Tr is the Ferm i tem perature), $_{\rm D}$ follows roughly a p $^{2:5}$ dependence upon either layer density (p). Note that as B $_{\rm jj}$ is increased, the traces still show m onotonic behavior, but the shape of each curve di ers more from that at zero

eld. The trace at $B_{jj} = 14$ T is drastically di erent from the zero eld trace, exhibiting a very sharp increase and then a crossover to a weaker dependence as p_{drive} is bw ered through matched density. It is clear from this, that the component of the drag arising from B_{jj} has quite a di erent dependence on density ratio than the zero eld component of $_D$. To exam ine the component of $_D$ which arises from B_{jj} m ore carefully, the strong zero eld background must be scaled out of the data. This is done in the inset, where the density sweep data at a

xed value of B_{jj} , is norm alized by the data at zero eld. Looking at the gure, it is clear that the enhancement to $_D$ from B_{ij} clearly shows a non-monotonic behavior



FIG. 3: D vs p_{drive} , for $p_{drag} = 2:15 \quad 10^{10}$ cm², at T = 300 m K. The curves are, from top to bottom, for B_{jj} = 14, 10, 5.3, 3, 2 and 0 T. Inset: Sam e data scaled by the dependence at B_{jj} = 0. From top to bottom, the curves are for B_{jj} = 14, 10, 5.3, 3, and 2 T. In both, m atched density is indicated by the dashed line.

upon density ratio, exhibiting a localm aximum at essentially m atched density. We would like to point out that the same equalitative behavior is also observed at T = 80 mK. However, due to sm all signal measurement limitations, obtaining the data for $p_{\rm drive} > 2.5 \ 10^{10}$ cm² at this tem perature was not possible. Another interesting feature is that at lower elds, it appears that the peak is slightly to the left of the m atched density point, and appears to shift towards it as B_{jj} increases. This peak at m atched density is quite supprising, in that it im plies that the nature of the component of _D arising from B_{jj} is quite di erent than the zero eld component, and we can provide no suitable explanation for it at this point.

The similarity between the B_{jj} dependence of and $_{\rm D}$ is quite astonishing, due to the fact that the nature of the resistivity and the drag are extremely dierent. Attempting to explain the origin of the magnetodrag seems a di cult task, primarily since, despite numerous studies accounting for percolation transport[16], screening changes[17], spin ip scattering[18, 19], and orbital e ects[20], there exists no de nitive explanation as to the origin of the single layer in-plane M R.At this point, som e comments on the properties of our magnetodrag data in light of a few of these mechanisms are in order.

We rst focus on the change in the screening properties as the system undergoes spin polarization. In single layer systems, the dominant contribution to the resistivity arises from ionized in purity scattering. Therefore, these studies [17] concentrated upon how the static screening of the ionized in purity potential changes as the system is spin polarized. It could be envisioned that $\sin -$ ilar changes in the screening could increase the strength of the interlayer C oloum b potential. In turn, this could lead to the observed enhancement of the drag with B_{jj}. How ever, in this case we would be concerned with the dynamic screening properties of the 2D system [21], which are quite di erent from the static properties.

W hile the sim ilarity of the magnetodrag and the MR o ers som e clues, any attem pts at understanding the origin of the component of $_{\rm D}\,$ arising from B $_{\rm ii}$ must focus upon explaining its sensitivity to matched density. A 1though screening changes could possibly explain the enhancement to $_{\rm D}$, it is dicult to see how they could give rise to a drag sensitive to matched density. The peak at m atched density shown in the inset of F ig 3 provides very in portant inform ation. It tells us that energy and momentum conservation lead to a suppression of the interlayer carrier-carrier scattering process, which gives rise to the magnetodrag, when the layer densities are mism atched. For example, this conservation leads to a peak at matched density in drag processes arising from phonon exchange[22] or 2k_F scattering [23]. How ever, from our zero eld density ratio data [10], we feel neither of these give rise to the magnetodrag. On the other hand, we comment on the possibility of intersubband scattering processes playing an important role in this regime. In these cases, energy and momentum conservation would lead to D exhibiting sensitivity at matched density.

In single layer MR studies, the e ect of nite layer thickness was taken into account by considering the coupling of B_{ii} to the orbital motion of the carriers[20]. In this model, the MR arises from an increase in the scattering rate between subbands produced by the con ning potential in the z direction, and the carrier spin does not play any role. This study was successful in providing one possible origin of the high eld MR observed in GaAs samples. Generalizing this mechanism to our double layer system, it is possible to envision an intersubband scattering process, between carriers in each layer. Here, a carrier in each layer would scatter into a di erent subband produced by its con ning potential. Making the assumption that the subband energies do not change with density and gate voltage (which is valid for this sam ple structure), then energy and m om entum conservation would suppress this process for m ism atched densities.

A nother intersubband scattering m echanism that can be envisioned is a spin- ip scattering process. Recent single layer experiments have provided evidence that m agnetic in purity spin- ip scattering could also play an important role in the in-plane m agnetotransport [18]. These studies concluded that the application of B_{jj} led to an increase in the spin- ip scattering rate, which in turn suppressed the \m etallic" behavior. In the drag it is not quite clear how an interlayer spin- ip scattering process can occur. W hereas, a carrier and m agnetic in purity can interact through spin exchange, there is no exchange in the interlayer carrier-carrier interaction potential in our double layer system. However, an indirect carrier scattering event via a m agnetic in purity can be envisioned, leading to a change in the spin states of the carriers. It is then possible that energy and m om entum conservation w ould require the Ferm iw ave vectors of each layer to be m atched.

In conclusion, we have found that the m agnetodrag exhibits exactly the same qualitative behavior as the single layer in-plane M R. In addition, we have found that the m agnetodrag is sensitive to the density ratio of the two layers, exhibiting a maximum at m atched density.

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